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# Cobalt Silicon Diphosphate, Co<sub>2</sub>Si(P<sub>2</sub>O<sub>7</sub>)<sub>2</sub>

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## Abstract

The structure of dicobalt(II) silicon bis[diphosphate-(4-)], Co<sub>2</sub>Si(P<sub>2</sub>O<sub>7</sub>)<sub>2</sub>, consists of compressed CoO<sub>6</sub> octahedra, SiO<sub>4</sub> tetrahedra and P<sub>2</sub>O<sub>7</sub> groups with a P—O—P angle of 132.3 (1)°. Co<sub>2</sub>O<sub>10</sub> units built from two edge-sharing CoO<sub>6</sub> octahedra are linked *via* four corners to other dimers, thus forming a two-dimensional network parallel to the *bc* plane. These planes are separated by bands formed from diphosphate groups and SiO<sub>4</sub> tetrahedra.

## Comment

In the course of our investigations of the thermal behaviour and crystal chemistry of anhydrous phosphates of transition metals, we obtained cobalt silicon diphosphate as a product of chemical transport experiments intended to crystallize Co<sub>2</sub>P<sub>4</sub>O<sub>12</sub> (Thilo & Grunze, 1957). After the isotypic Cd<sub>2</sub>Si(P<sub>2</sub>O<sub>7</sub>)<sub>2</sub> (Trojan, Brandová, Fábry, Hybler, Jurek & Petrícek, 1987),  $Co_2Si(P_2O_7)_2$  is only the second mixed anhydrous phosphate of silicon with a late transition metal to be identified, whereas phosphates of silicon and the early transition metals, e.g. (VO)Si(PO<sub>4</sub>)<sub>2</sub> (Middlemiss & Calvo, 1976), V<sub>3</sub>P<sub>5</sub>SiO<sub>19</sub> (Leclaire, Chaboun, Groult & Raveau, 1986) and Mo<sub>4</sub>P<sub>6</sub>Si<sub>2</sub>O<sub>25</sub> (Leclaire, Lamire & Raveau, 1988), have been known for some time. An even wider variety of phosphate silicates is obtained by the introduction of alkali metals or alkaline earth metals in addition to the early transition metal (e.g. see Leclaire, Monier & Raveau, 1985).

The structure of  $Co_2Si(P_2O_7)_2$  consists of compressed  $CoO_6$  octahedra, almost ideal  $SiO_4$  tetrahedra and  $P_2O_7$  groups with an eclipsed conformation similar to that found in the triclinic modification of  $GeP_2O_7$  (Kaiser & Glaum, 1994). The P—O—P bridging angle of 132.3 (1)° is rather small as a result of a chelate-type coordination to  $Co^{2+}$  (Fig. 1*a*). Two remarkably different P—O—Si bridging angles of 140.8 (1) and 168.9 (1)° are observed for  $Co_2Si(P_2O_7)_2$ , compared to 141.7 to 153.3° found in SiP\_2O\_7 (Tillmans, Gebert & Baur, 1973).

The structure contains seven independent O-atom sites. Two show threefold coordination (by one P atom



Fig. 1. (a) Projection of the title structure on the ac plane with schematic coordination polyhedra;  $P_2O_7$  light grey,  $SiO_4$  medium grey,  $CoO_6$  dark grey. (b) Projection on the bc plane of sheets comprising dimeric  $Co_2O_{10}$  units. Both views were produced using ATOMS (Dowty, 1995).

and two Co atoms) while the other five show twofold coordination either by two P atoms, a P and an Si atom (twice) or a P and a Co atom (twice). As expected, the bond lengths around an O atom depend on its coordination number and the valence of the counter cations. Within the diphosphate group, the P— O distance to the bridging O atom is about 0.04 Å longer than to the O atom bonded to Si. The P— O bonds to those  $O^{2-}$  ions further bonded to Co are rather short [1.483 (2)–1.513 (2) Å]. These differences in bond length within the PO<sub>4</sub> groups are in agreement with bond length–bond strength considerations. Similar relations were observed in other diphosphates, *e.g.* SiP<sub>2</sub>O<sub>7</sub> (Tillmans, Gebert & Baur, 1973).

Co is octahedrally coordinated by O atoms with two short (*ca* 1.98 Å) and four long (*ca* 2.28 Å) bonds. Two CoO<sub>6</sub> octahedra are linked by edge-sharing, thus forming Co<sub>2</sub>O<sub>10</sub> units. These are connected by four corners with other dimers to form a two-dimensional network parallel to the *bc* plane (Fig. 1*b*). These planes are separated by bands formed from diphosphate groups and SiO<sub>4</sub> tetrahedra.

In contrast to red-violet  $Co_2P_4O_{12}$ , which contains only slightly distorted  $CoO_6$  octahedra, the compressed octahedral geometry around  $Co^{2+}$  in the title compound leads to a pale blue-violet colour.

In addition to Co<sub>2</sub>Si(P<sub>2</sub>O<sub>7</sub>)<sub>2</sub>, three isotypic diphosphates  $M_2$ Si(P<sub>2</sub>O<sub>7</sub>)<sub>2</sub> (M = Fe, Ni, Cu) have been synthesized. Their lattice parameters at ambient temperature were determined from Guinier photographs [Fe<sub>2</sub>Si(P<sub>2</sub>O<sub>7</sub>)<sub>2</sub>: a = 16.909 (6), b = 4.991 (1), c = 12.381 (5) Å,  $\beta = 103.32$  (3)°; Ni<sub>2</sub>Si(P<sub>2</sub>O<sub>7</sub>)<sub>2</sub>: a = 16.892 (5), b = 4.900 (1), c = 12.215 (4) Å,  $\beta = 103.73$  (3)°; Cu<sub>2</sub>Si(P<sub>2</sub>O<sub>7</sub>)<sub>2</sub>: a = 17.38 (1), b = 4.70 (1), c = 12.28 (1) Å,  $\beta = 105.6$  (1)°; Glaum, Hofmann & Schmidt (1996)].

## Experimental

Single crystals of  $Co_2Si(P_2O_7)_2$  suitable for X-ray singlecrystal investigations were grown by isothermal heating of  $Co_2P_4O_{12}$  (Thilo & Grunze, 1957) in silica ampoules at 1173 K under 3 atm (1 atm = 101 325 Pa) of chlorine as mineralizer. Migration in a temperature gradient from 1223 to 1123 K was not observed. Microcrystalline  $Co_2Si(P_2O_7)_2$  was obtained as a single phase by heating pellets of stoichiometric mixtures of  $Co_2P_4O_{12}$  and amorphous  $SiO_2$  in silica ampoules at 1173 K using 10 mg NH<sub>4</sub>Cl as mineralizer.

Crystal data

Co<sub>2</sub>Si(P<sub>2</sub>O<sub>7</sub>)<sub>2</sub>  $M_r = 493.83$ Monoclinic C2/c a = 16.897 (2) Å b = 4.9442 (5) Å c = 12.2950 (10) Å  $\beta = 103.418 (9)^{\circ}$   $V = 999.1 (2) Å^{3}$  Z = 4  $D_r = 3.283 \text{ Mg m}^{-3}$  $D_m$  not measured

Data collectionAED-2 diffractometer $\theta/2\theta$  scansAbsorption correction: $\psi$  scan (North, Phillips $\psi$  scan (North, Phillips $\psi$  Mathews, 1968) $T_{min} = 0.587, T_{max} =$ 0.7255468 measured reflections1446 independent reflections

#### Refinement

Refinement on  $F^2$   $R[F^2 > 2\sigma(F^2)] = 0.0200$   $wR(F^2) = 0.0505$  S = 1.0471446 reflections Mo  $K\alpha$  radiation  $\lambda = 0.71069$  Å Cell parameters from 68 reflections (19 independent)  $\theta = 16.5-24.9^{\circ}$   $\mu = 4.174$  mm<sup>-1</sup> T = 293 (2) K Plate  $0.10 \times 0.08 \times 0.02$  mm Pale violet

1123 observed reflections  $[I > 2\sigma(I)]$   $R_{int} = 0.0381$   $\theta_{max} = 29.95^{\circ}$   $h = -23 \rightarrow 23$   $k = -6 \rightarrow 6$   $l = -17 \rightarrow 17$ 3 standard reflections frequency: 120 min intensity decay: none

Extinction correction: SHELXL93 (Sheldrick, 1993) Extinction coefficient: 0.0018 (2)

97 parameters  

$$w = 1/[\sigma^2(F_o^2) + (0.0247P)^2 + 0.5839P]$$
  
where  $P = (F_o^2 + 2F_c^2)/3$   
 $(\Delta/\sigma)_{max} < 0.001$   
 $\Delta\rho_{max} = 0.408 \text{ e} \text{ Å}^{-3}$   
 $\Delta\rho_{min} = -0.404 \text{ e} \text{ Å}^{-3}$ 

Atomic scattering factors from *International Tables* for Crystallography (1992, Vol. C, Tables 4.2.6.8 and 6.1.1.4)

 
 Table 1. Fractional atomic coordinates and equivalent isotropic displacement parameters (Å<sup>2</sup>)

$$U_{\rm eq} = (1/3) \sum_i \sum_j U_{ij} a_i^* a_j^* \mathbf{a}_i \cdot \mathbf{a}_j.$$

	х	у	z	$U_{ea}$
Co	0.24670(2)	0.14994 (6)	0.62975 (2)	0.00773 (9)
Si	0	0.8439 (2)	3/4	0.00535 (15)
PI	0.12470 (3)	0.63442 (12)	0.63418 (4)	0.00626 (11)
P2	0.13536(3)	0.83091 (11)	0.41479 (4)	0.00596 (11)
01	0.04428 (9)	0.6531 (3)	0.67674 (12)	0.0090 (3)
O2	0.14261 (9)	0.3447 (3)	0.61930(12)	0.0111 (3)
O3	0.30755 (9)	0.3038 (3)	0.79627 (12)	0.0099 (3)
O4	0.09356 (10)	0.7791 (3)	0.51626(12)	0.0101 (3)
O5	0.34594 (9)	-0.0690(3)	0.63241 (12)	0.0108 (3)
O6	0.20389 (9)	1.0275 (3)	0.45361 (12)	0.0099 (3)
07	0.06365 (10)	0.9656 (3)	0.33043 (13)	0.0126 (3)

#### Table 2. Selected geometric parameters (Å, °)

Co02	1.983 (2)	Si—O1''	1.604 (2)
Co-05	1.990 (2)	P1	1.484(2)
Co	2.165 (2)	P1—O3`"	1.513(2)
Co-03	2.2024 (15)	P101	1.568 (2)
Co06"	2.2028 (15)	P104	1.593 (2)
Co-03 <sup>111</sup>	2.232 (2)	P2-05 <sup>vm</sup>	1,483(2)
Si—O7 <sup>w</sup>	1.590(2)	P2—O6	1.502(2)
Si—07`	1.590(2)	P2—O7	1.551(2)
Si-01	1.604 (2)	P2—O4	1.591 (2)
P1—O1—Si	140.81 (11)	P2`'''O5Co	136.39 (10)
P1	131.60 (10)	P2-06-Co'	132.82 (9)
P1 <sup>III</sup> O3Co	117.59 (8)	P2-06-Co <sup>1x</sup>	122.90 (9)
P1 <sup>III</sup> O3Co <sup>vII</sup>	121.50 (8)	Co <sup>1</sup>	100.85 (6)
СоО3Со <sup>чи</sup>	119.76 (7)	P2—O7—Si <sup>v</sup>	168.89 (13)
P2-04-P1	132.33 (11)		
<b>c</b>			

Symmetry codes: (i)  $\frac{1}{2} - x$ ,  $\frac{3}{2} - y$ , 1 - z; (ii) x, y - 1, z; (iii)  $\frac{1}{2} - x$ ,  $y - \frac{1}{2}$ ,  $\frac{3}{2} - z$ ; (iv) x, 2 - y,  $\frac{1}{2} + z$ ; (v) -x, 2 - y, 1 - z; (vi) -x, y,  $\frac{3}{2} - z$ ; (vii)  $\frac{1}{2} - x$ ,  $\frac{1}{2} + y$ ,  $\frac{3}{2} - z$ ; (viii)  $\frac{1}{2} - x$ ,  $\frac{1}{2} - y$ , 1 - z; (ix) x, 1 + y, z.

Data collection: *Stadi-4 Software* using the peak/background method (Stoe & Cie, 1995). Cell refinement: *Stadi-4 Software*. Data reduction: *Stadi-4 Software*. Program(s) used to solve structure: *SHELXS*86 (Sheldrick, 1990). Program(s) used to refine structure: *SHELXL*93 (Sheldrick, 1993). Molecular graphics: *ATOMS* (Dowty, 1995). Software used to prepare material for publication: *SHELXL*93.

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Lists of structure factors, anisotropic displacement parameters and complete geometry have been deposited with the IUCr (Reference: JZ1108). Copies may be obtained through The Managing Editor, International Union of Crystallography, 5 Abbey Square, Chester CH1 2HU, England.

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